

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/925,331	VENKEN ET AL.	
Examiner		Art Unit		Page 1 of 1
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*	B	US-6,094,418	07-2000	Soumiya et al.	370/231
*	C	US-6,452,905	09-2002	Smith et al.	370/236.1
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**NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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